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## Efficiency Test of Diamond Phase Retarder and Polarization Analysis

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X-ray transmission phase plate has opened out wide application for magnetic scattering and absorption experiments [1]. The phase plate functions both as a  $\lambda/4$ -phase plate to convert linear polarization to circular one and as a  $\lambda/2$ -phase plate to generate vertical linear polarization. In this work, to estimate the efficiency of a diamond phase plate, the polarization state of the converted X-rays is characterized by polarization analysis.

A synthetic diamond (111) crystal slab 0.73 mm in thickness was operated around the 220 reflection in transmission Laue geometry. A Si(331) channel-cut crystal was mounted on the  $\chi$ -axis of 4-circle goniometer together with a scintillation counter.

Degree of polarization was estimated from the angle dependence of intensity expressed as follows:

$$I(\chi) = S_0 + S_1 \cos 2\chi + S_2 \sin 2\chi, \qquad (1)$$

where  $S_0$  is an angle-independent term,  $S_1$  and  $S_2$  correspond to the components of Stokes parameter  $P_3$ . In linear polarization, degrees of  $\pi$  and  $\sigma$  polarizations can be estimated by  $S_1/S_0$  and  $S_2/S_0$ , and degree of circular one was derived from  $\sqrt{[1-(S_1/S_0)^2-(S_2/S_0)^2]}$  on the assumption of no-unpolarized term.

On this beamline the linearly polarized X-rays ( $\pi$  polarization) emitted from a linear undulator are originally available. Degree of linear polarization at 7.1195keV was evaluated to be 0.998 by a logarithmic fitting to eq.(1). Such a high rate is suitable for not only the magnetic scattering but also a conversion to other polarization states. Indeed, the linearly polarized incident X-ray can be converted to

the circular polarization by adjusting an offset angle from the Bragg condition so as to produce a  $\pi/4$  phase shift. Degree of circular polarization was also estimated to be 0.997. Another conversion is to generate a vertical linear ( $\sigma$ ) polarization as a  $\lambda/2$ -phase plate. Degree of linear polarization was evaluated to be 0.82. This deterioration is possibly due to the contamination of simultaneous reflections and/or higher harmonics of the undulator light. Figure 1 shows the angle dependence of intensity for each of the polarization state.

The present test clearly demonstrates that the phase retarder functions as both a  $\lambda/4$ - and a  $\lambda/2$ -phase plate, and that the converted X-ray has a high-rate of degree of polarization.

## References

[1] K.Hirano and H.Maruyama; Jpn.J.Appl. Phys., **36** (1997) L1272.

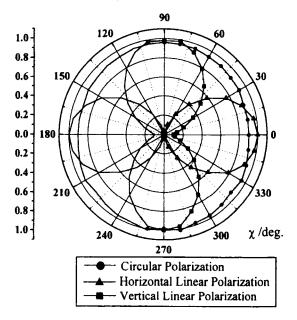


Fig. 1. Angle dependence of X-ray intensity.